

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)		
30	0.0149 at V _{GS} = 10 V	20	15nC		
30	0.019 at $V_{GS} = 4.5 \text{ V}$	16	13110		

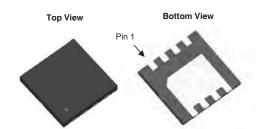
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

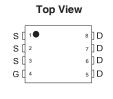


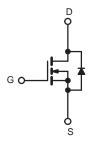
APPLICATIONS

- · Notebook PC Core
- VRM/POL



DFN 3x3 EP





N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		20 ^{a, e}		
Continuous Drain Current (T. – 175 °C)	T _C = 70 °C	I-	18 ^e	7	
Continuous Drain Current (T _J = 175 °C)	T _A = 25 °C	I _D	15 ^{b, c}	A	
	T _A = 70 °C		13 ^{b, c}		
Pulsed Drain Current		I _{DM}	60		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	17		
Single Pulse Avalanche Energy		E _{AS}	16	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	18 ^{a, e}	А	
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	13 ^{b, c}	A	
	T _C = 25 °C		16		
Maximum Power Dissipation	T _C = 70 °C	P _D	7	W	
	T _A = 25 °C	' D	4.5 ^{b, c}		
	T _A = 70 °C		2.6 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	31	44	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	3	4		

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 s.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature.



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			>	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.5		mv/·C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	Inno	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	۸	
Zero Gate Voltage Drain Gurrent	I _{DSS}	V _{DS} = 24 V, V _{GS} = 0 V, T _J = 55 °C			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	60			Α	
	В	V _{GS} = 10 V, I _D = 10 A		0.0149	0.017	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.019	0.022		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 24 \text{ V}, I_{D} = 10 \text{ A}$		35		S	
Dynamic ^b							
Input Capacitance	C _{iss}			655			
Output Capacitance	C _{oss}	$V_{DS} = 24V, V_{GS} = 0 V, f = 1 MHz$		422		pF	
Reverse Transfer Capacitance	C _{rss}			109			
Total Gate Charge	Qg	$V_{DS} = 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		14			
				6.6		nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 24 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		4			
Gate-Drain Charge	Q_{gd}			3			
Gate Resistance	R_{g}	f = 1 MHz		3		Ω	
Turn-On Delay Time	t _{d(on)}			11			
Rise Time	t _r	$V_{DD} = 24 \text{ V}, R_L = 1.8 \Omega$		9			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 3 \Omega$		25			
Fall Time	t _f			12			
Turn-On Delay Time	t _{d(on)}			20		ns	
Rise Time	t _r	$V_{DD} = 24 \text{ V}, R_L = 1.8 \Omega$		17		-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 8 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 3 \Omega$		50			
Fall Time	t _f			18			
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			18	۸	
Pulse Diode Forward Current ^a	I _{SM}				54	А	
Body Diode Voltage	V _{SD}	I _S = 10 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			10		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, di/dt = 100 A/µs, T _{.1} = 25 °C		15		nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ al/at} = 100 \text{ A/}\mu\text{s}, I_J = 25 ^{\circ}\text{C}$		20			
Reverse Recovery Rise Time	t _b	_		22		ns	

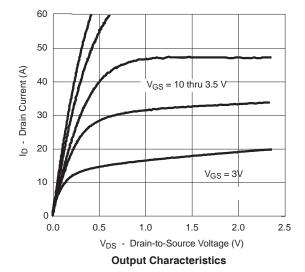
Notes:

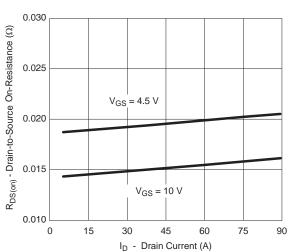
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

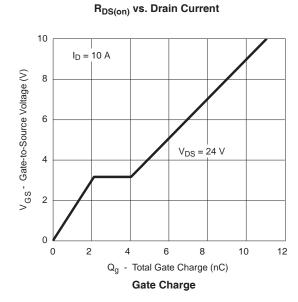
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

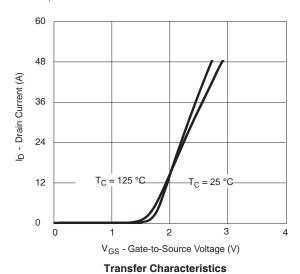


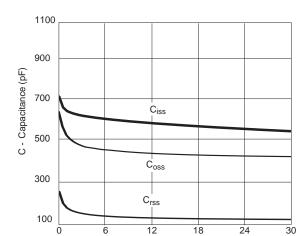
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



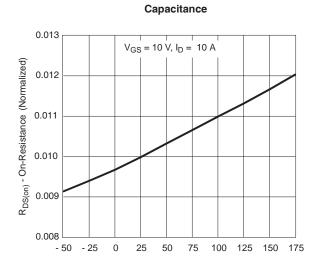








 $V_{\mbox{\footnotesize DS}}$ - Drain-to-Source Voltage (V)

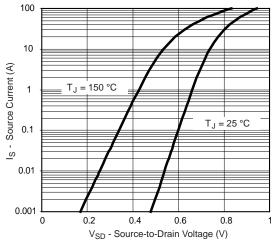


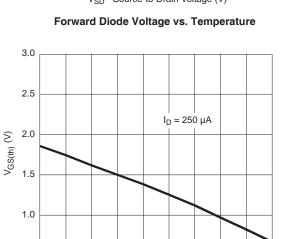
On-Resistance vs. Junction Temperature





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

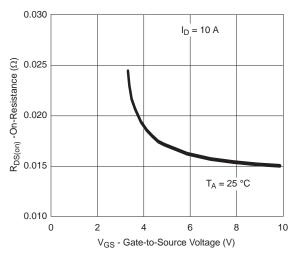




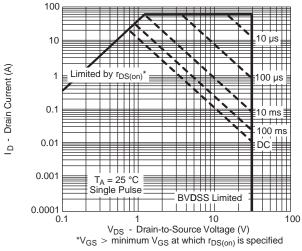
T_J - Temperature (°C)

Threshold Voltage

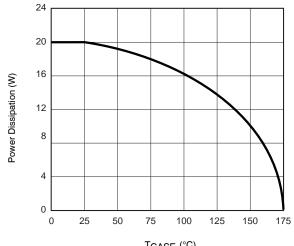
75 100 125 150 175



 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Safe Operating Area, Junction-to-Ambient



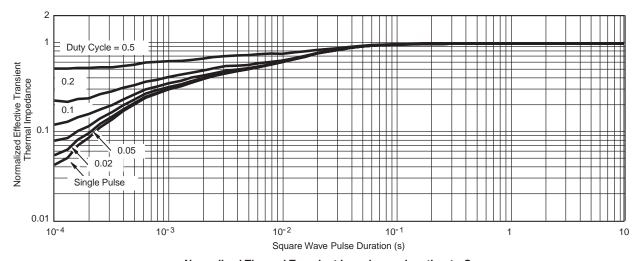
T_{CASE} (°C)
Power Derating

0.5

- 50 - 25

0 25 50

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

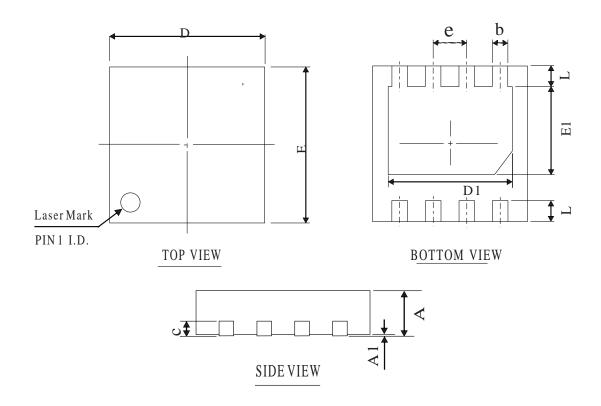


Normalized Thermal Transient Impedance, Junction-to-Case

Din-Tek SEMICONDUCTOR



DFN3*3-8L PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	0. 60	0.75	0. 90
A1	0. 00	0.02	0. 08
b	0. 20	0.30	0.45
D	2. 85	3.00	3. 15
E	2. 85	3.00	3. 15
D1	2. 10	2.40	2.70
E1	1.50	1.70	2.00
L	0. 20	0.40	0.60
С	0. 203 REF		
e	0. 65 BSC		

OTHER DIMENSIONS

A	0. 50	0.55	0.60
A	0.40	0.45	0. 50





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